## 16-Ch/Dual 8-Ch High-Performance CMOS Analog Multiplexers

## DESCRIPTION

The DG406B is a 16-channel single-ended analog multiplexer designed to connect one of sixteen inputs to a common output as determined by a 4-bit binary address. The DG407B selects one of eight differential inputs to a common differential output. Break-before-make switching action protects against momentary shorting of inputs.
An on channel conducts current equally well in both directions. In the off state each channel blocks voltages up to the power supply rails. An enable (EN) function allows the user to reset the multiplexer/demultiplexer to all switches off for stacking several devices. All control inputs, address $\left(A_{x}\right)$ and enable (EN) are TTL compatible over the full specified operating temperature range.
Applications for the DG406B, DG407B include high speed data acquisition, audio signal switching and routing, ATE systems, and avionics. High performance and low power dissipation make them ideal for battery operated and remote instrumentation applications.
Designed in the 44 V silicon-gate CMOS process, the absolute maximum voltage rating is extended to 44 V , allowing operation with $\pm 20 \mathrm{~V}$ supplies. Additionally single (12 V) supply operation is allowed. An epitaxial layer prevents latchup.

## FEATURES

- Low on-resistance - $\mathrm{R}_{\mathrm{DS}(o n)}$ : $45 \Omega$
- Low charge injection - Q: 11 pC
- Fast transition time - $\mathrm{t}_{\text {TRANs }} 115 \mathrm{~ns}$
- Low power: 0.2 mW
- Single supply capability
- Material categorization: For definitions of compliance please see www.vishay.com/doc?99912


## Note

* This datasheet provides information about parts that are RoHS-compliant and/or parts that are non-RoHS-compliant. For example, parts with lead (Pb) terminations are not RoHS-compliant. Please see the information/tables in this datasheet for details.


## BENEFITS

- Higher accuracy
- Reduced glitching
- Improved data throughput
- Reduced power consumption
- Increased ruggedness
- Wide supply ranges: $\pm 5 \mathrm{~V}$ to $\pm 20 \mathrm{~V}$


## APPLICATIONS

- Data acquisition systems
- Audio signal routing
- Medical instrumentation
- ATE systems
- Battery powered systems
- High-rel systems
- Single supply systems


## FUNCTIONAL BLOCK DIAGRAM AND PIN CONFIGURATION

DG406B


DG407B


## FUNCTIONAL BLOCK DIAGRAM AND PIN CONFIGURATION



| TRUTH TABLE (DG406B) |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathbf{A}_{\mathbf{3}}$ | $\mathbf{A}_{\mathbf{2}}$ | $\mathbf{A}_{\mathbf{1}}$ | $\mathbf{A}_{\mathbf{0}}$ | EN | ON SWITCH |
| X | X | X | X | 0 | None |
| 0 | 0 | 0 | 0 | 1 | 1 |
| 0 | 0 | 0 | 1 | 1 | 2 |
| 0 | 0 | 1 | 0 | 1 | 3 |
| 0 | 0 | 1 | 1 | 1 | 4 |
| 0 | 1 | 0 | 0 | 1 | 5 |
| 0 | 1 | 0 | 1 | 1 | 6 |
| 0 | 1 | 1 | 0 | 1 | 7 |
| 0 | 1 | 1 | 1 | 1 | 8 |
| 1 | 0 | 0 | 0 | 1 | 9 |
| 1 | 0 | 0 | 1 | 1 | 10 |
| 1 | 0 | 1 | 0 | 1 | 11 |
| 1 | 0 | 1 | 1 | 1 | 12 |
| 1 | 1 | 0 | 0 | 1 | 13 |
| 1 | 1 | 0 | 1 | 1 | 14 |
| 1 | 1 | 1 | 0 | 1 | 15 |
| 1 | 1 | 1 | 1 | 1 | 16 |


| ORDERING INFORMATION (DG406B) |  |  |
| :---: | :---: | :---: |
| TEMP. RANGE | PACKAGE | PART NUMBER |
|  | 28 -Pin Plastic DIP | DG406BDJ, <br> DG406BDJ-E3 |
| $-40^{\circ} \mathrm{C}$ to $85^{\circ} \mathrm{C}$ | 28 -Pin PLCC | DG406BDN, <br> DG406BDN-T1-E3 |
|  | 28-Pin Widebody <br> SOIC | DG406BDW, <br> DG406BDW-E3, <br> DG406BDW-T1-E3 |

DG407B


| TRUTH TABLE (DG407B) |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: |
| $\mathbf{A}_{\mathbf{2}}$ | $\mathbf{A}_{\mathbf{1}}$ | $\mathbf{A}_{\mathbf{0}}$ | $\mathbf{E N}$ | ON SWITCH |
| X | X | X | 0 | None |
| 0 | 0 | 0 | 1 | 1 |
| 0 | 0 | 1 | 1 | 2 |
| 0 | 1 | 0 | 1 | 3 |
| 0 | 1 | 1 | 1 | 4 |
| 1 | 0 | 0 | 1 | 5 |
| 1 | 0 | 1 | 1 | 6 |
| 1 | 1 | 0 | 1 | 7 |
| 1 | 1 | 1 | 1 | 8 |

## Notes

- Logic " 0 " $=\mathrm{V}_{\mathrm{AL}} \leq 0.8 \mathrm{~V}$
- Logic "1" $=\mathrm{V}_{\mathrm{AH}} \geq 2.4 \mathrm{~V}$
- $X=$ Do not care

Note

- -T1 indicates Tape and Reel, -E3 indicates Lead-Free and RoHS Compliant, NO -E3 indicates standard Tin/Lead finish.

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| ABSOLUTE MAXIMUM RATINGS |  |  |  |
| :---: | :---: | :---: | :---: |
| PARAMETER |  | LIMIT | UNIT |
| Voltages Referenced to V- | V+ to V-9 | 44 | V |
|  | GND to V- | -25 |  |
| Digital Inputs ${ }^{\text {a }}$, $\mathrm{V}_{\mathrm{S}}, \mathrm{V}_{\mathrm{D}}$ |  | (V-) - 2 to (V+) + 2 or 20 mA , whichever occurs first |  |
| Current (any terminal) |  | 30 | mA |
| Peak Current, S or D (pulsed at $1 \mathrm{~ms}, 10$ \% duty cycle max.) |  | 100 |  |
| Storage Temperature |  | -65 to 150 | ${ }^{\circ} \mathrm{C}$ |
| Power Dissipation (Package) ${ }^{\text {b }}$ | 28-Pin Plastic DIP ${ }^{\text {c }}$ | 625 | mW |
|  | 28-Pin Plastic PLCC ${ }^{\text {c }}$ | 450 | mW |
|  | 28-Pin Widebody SOIC ${ }^{\text {f }}$ | 450 | mW |

## Notes

a. Signals on $\mathrm{S}_{\mathrm{X}}$, $\mathrm{D}_{\mathrm{X}}$ or $\mathrm{IN}_{\mathrm{X}}$ exceeding $\mathrm{V}+$ or V - will be clamped by internal diodes. Limit forward diode current to maximum current ratings.
b. All leads soldered or welded to PC board.
c. Derate $8.3 \mathrm{~mW} /{ }^{\circ} \mathrm{C}$ above $75^{\circ} \mathrm{C}$.
d. Derate $16 \mathrm{~mW} /{ }^{\circ} \mathrm{C}$ above $75^{\circ} \mathrm{C}$.
e. Derate $18 \mathrm{~mW} /{ }^{\circ} \mathrm{C}$ above $75^{\circ} \mathrm{C}$.
f. Derate $6 \mathrm{~mW} /{ }^{\circ} \mathrm{C}$ above $75^{\circ} \mathrm{C}$.
g. Also applies when $\mathrm{V}-=\mathrm{GND}$.

| SPECIFICATIONS |  |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| PARAMETER |  | SYMBOL | TEST CONDITIONS UNLESS OTHERWISE SPECIFIED | TEMP. ${ }^{\text {b }}$ | TYP. ${ }^{\text {c }}$ |  | $\begin{aligned} & \text { IX } \\ & 85^{\circ} \mathrm{C} \end{aligned}$ | UNIT |
|  |  | $\begin{gathered} \mathrm{V}+=15 \mathrm{~V}, \mathrm{~V}-=-15 \mathrm{~V} \\ \mathrm{~V}_{\mathrm{AL}}=0.8 \mathrm{~V}, \mathrm{~V}_{\mathrm{AH}}=2.4 \mathrm{~V}^{\mathrm{f}} \end{gathered}$ | MIN. ${ }^{\text {d }}$ |  |  | MAX. ${ }^{\text {d }}$ |  |
| Analog Switch |  |  |  |  |  |  |  |  |
| Analog Signal Range ${ }^{\text {e }}$ |  |  | $\mathrm{V}_{\text {ANALOG }}$ |  | Full | - | -15 | 15 | V |
| Drain-Source On-Resistance |  | $\mathrm{R}_{\mathrm{DS} \text { (on) }}$ | $\mathrm{V}_{\mathrm{D}}= \pm 10 \mathrm{~V}, \mathrm{I}_{\mathrm{S}}=-10 \mathrm{~mA}$ sequence each switch on | Room | 45 | - | 60 | $\Omega$ |
|  |  | Full |  | 45 | - | 74 |  |
| $\mathrm{R}_{\mathrm{DS}(\text { on })}$ Matching Between Channels ${ }^{9}$ |  |  | $\Delta \mathrm{R}_{\mathrm{DS} \text { (on) }}$ | $\mathrm{V}_{\mathrm{D}}= \pm 10 \mathrm{~V}$ | Room | 5 | - | - | \% |
| Source Off Leakage Current |  | $\mathrm{I}_{\text {S(off) }}$ | $\begin{gathered} \mathrm{V}_{\mathrm{S}}= \pm 10 \mathrm{~V} \\ \mathrm{~V}_{\mathrm{D}}= \pm 10 \mathrm{~V}, \mathrm{~V}_{\mathrm{EN}}=0 \mathrm{~V} \end{gathered}$ | Room | - | -0.5 | 0.5 | nA |
|  |  | Full |  | - | -5 | 5 |  |
| Drain Off Leakage Current | DG406B |  | $\mathrm{I}_{\mathrm{D} \text { (off) }}$ | $\begin{aligned} & \mathrm{V}_{\mathrm{D}}= \pm 10 \mathrm{~V}, \\ & \mathrm{~V}_{\mathrm{S}}= \pm 10 \mathrm{~V}, \\ & \mathrm{~V}_{\mathrm{EN}}=0 \mathrm{~V} \end{aligned}$ | Room | - | -1 |  | 1 |
|  | DG406B | Full |  |  | - | -40 | 40 |  |
|  | DG407B | Room |  |  | - | -1 | 1 |  |
|  |  | Full |  |  | - | -20 | 20 |  |
| Drain On Leakage Current | DG406B | $\mathrm{I}_{\mathrm{D} \text { (on) }}$ | $V_{S}=V_{D}= \pm 10 \mathrm{~V}$ <br> sequence each switch on | Room | - | -1 | 1 |  |
|  | DG406B |  |  | Full | - | -40 | 40 |  |
|  | DG407B |  |  | Room | - | -1 | 1 |  |
|  |  |  |  | Full | - | -20 | 20 |  |
| Digital Control |  |  |  |  |  |  |  |  |
| Logic High Input Voltage |  | $\mathrm{V}_{\text {INH }}$ |  | Full | - | 2.4 | - | V |
| Logic Low Input Voltage |  | $\mathrm{V}_{\text {INL }}$ |  | Full | - | - | 0.8 |  |
| Logic High Input Current |  | $\mathrm{I}_{\text {AH }}$ | $\mathrm{V}_{\mathrm{A}}=2.4 \mathrm{~V}, 15 \mathrm{~V}$ | Full | - | -1 | 1 | $\mu \mathrm{A}$ |
| Logic Low Input Current |  | $\mathrm{I}_{\mathrm{AL}}$ | $\mathrm{V}_{\mathrm{EN}}=0 \mathrm{~V}, 2.4 \mathrm{~V}, \mathrm{~V}_{\mathrm{A}}=0 \mathrm{~V}$ | Full | - | -1 | 1 |  |
| Logic Input Capacitance |  | $\mathrm{C}_{\text {in }}$ | $\mathrm{f}=1 \mathrm{MHz}$ | Room | 6 | - | - | pF |

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| SPECIFICATIONS |  |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| PARAMETER |  | SYMBOL | TEST CONDITIONS UNLESS OTHERWISE SPECIFIED | TEMP. ${ }^{\text {b }}$ | TYP. ${ }^{\text {c }}$ | $\begin{array}{r} D \\ -40^{\circ} \end{array}$ | $\begin{aligned} & =1 X \\ & 85^{\circ} \mathrm{C} \end{aligned}$ | UNIT |
|  |  | $\mathrm{V}+=15 \mathrm{~V}, \mathrm{~V}-=-15 \mathrm{~V}$ | MIN. ${ }^{\text {d }}$ |  |  | MAX. ${ }^{\text {d }}$ |  |
|  |  | $\mathrm{V}_{\mathrm{AL}}=0.8 \mathrm{~V}, \mathrm{~V}_{\mathrm{AH}}=2.4 \mathrm{~V}^{\text {f }}$ |  |  |  |  |  |
| Dynamic Characteristics |  |  |  |  |  |  |  |  |
| Transition Time |  |  | ${ }^{\text {t }}$ TRANS | see figure 2 | Room | 115 | - | 148 | ns |
|  |  | Full |  |  | - | - | 161 |  |  |
| Break-Before-Make Interval |  |  | topen | see figure 4 | Room | 39 | 10 | - |  |
|  |  | Full |  |  | - | 21 | - |  |  |
| Enable Turn-On Time |  | $\mathrm{t}_{\text {ON(EN }}$ | see figure 3 | Room | 75 | - | 107 |  |  |
|  |  | Full |  | - | - | 123 |  |  |
| Enable Turn-Off Time |  |  |  | $\mathrm{t}_{\text {OFF(EN) }}$ | Room | 50 | - | 88 |  |
|  |  | Full |  |  | - | - | 94 |  |  |
| Charge Injection |  | Q | $\begin{gathered} \mathrm{C}_{\mathrm{L}}=1 \mathrm{nF}, \mathrm{~V}_{\mathrm{S}}=0 \mathrm{~V} \\ \mathrm{R}_{\mathrm{S}}=0 \Omega \end{gathered}$ | Room | 11 | - | - | pC |  |
| Off Isolation ${ }^{\text {h }}$ |  | OIRR | $\begin{gathered} \mathrm{V}_{\mathrm{EN}}=0 \mathrm{~V}, \mathrm{R}_{\mathrm{L}}=50 \Omega, \\ \mathrm{f}=1 \mathrm{MHz} \end{gathered}$ | Room | -86 | - | - | dB |  |
| Source Off Capacitance |  | $\mathrm{C}_{\text {S(off) }}$ | $\begin{gathered} \mathrm{V}_{\mathrm{EN}}=0 \mathrm{~V}, \mathrm{~V}_{\mathrm{S}}=0 \mathrm{~V}, \\ \mathrm{f}=1 \mathrm{MHz} \end{gathered}$ | Room | 6 | - | - | pF |  |
| Drain Off Capacitance |  | $\mathrm{C}_{\mathrm{D} \text { (fff) }}$ | $\begin{aligned} & V_{E N}=0 \mathrm{~V}, \\ & V_{D}=0 \mathrm{~V}, \\ & f=1 \mathrm{MHz} \end{aligned}$ | Room | 108 | - | - |  |  |
|  | DG407B |  |  | Room | 54 | - | - |  |  |
| Drain On Capacitance | DG406B | $C_{\text {d(on) }}$ |  | Room | 114 | - | - |  |  |
|  | DG407B |  |  | Room | 57 | - | - |  |  |
| Power Supplies |  |  |  |  |  |  |  |  |  |
| Positive Supply Current |  | I+ | $\mathrm{V}_{\mathrm{EN}}=\mathrm{V}_{\mathrm{A}}=0 \mathrm{~V}$ or 5 V | Room | 23 | - | 30 | $\mu \mathrm{A}$ |  |
|  |  | Full |  | - | - | 75 |  |  |
| Negative Supply Current |  |  |  | I- | Room | -0.02 | -1 |  | - |
|  |  | Full |  |  | - | -10 | - |  |  |
| Positive Supply Current |  | I+ | $\mathrm{V}_{\mathrm{EN}}=2.4 \mathrm{~V}, \mathrm{~V}_{\mathrm{A}}=0 \mathrm{~V}$ | Room | 28 | - | 500 |  |  |
|  |  | Full |  | - | - | 700 |  |  |
| Negative Supply Current |  |  |  | I- | Room | -0.01 | -20 |  | - |
|  |  | Full |  |  | - | -20 | - |  |  |

## Notes

a. Guaranteed by $\pm 15 \mathrm{~V}$ leakage test, not production tested.
b. Room $=25^{\circ} \mathrm{C}$, Full $=$ as determined by the operating temperature suffix.
c. Typical values are for DESIGN AID ONLY, not guaranteed nor subject to production testing.
d. The algebraic convention whereby the most negative value is a minimum and the most positive a maximum, is used in this datasheet.
e. Guaranteed by design, not subject to production test.
f. $\mathrm{V}_{\mathrm{IN}}=$ input voltage to perform proper function.
g. $\Delta \mathrm{R}_{\mathrm{DS}(\text { (on })}=\mathrm{R}_{\mathrm{DS}(\text { on })} \mathrm{max} .-\mathrm{R}_{\mathrm{DS}(\text { on })} \mathrm{min}$.
h. Worst case isolation occurs on channel 4 due to proximity to the drain pin.

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## SPECIFICATIONS FOR SINGLE SUPPLY

| PARAMETER |  | SYMBOL | TEST CONDITIONS UNLESS OTHERWISE SPECIFIED | TEMP. ${ }^{\text {b }}$ | TYP. ${ }^{\text {c }}$ | $\begin{gathered} \text { D SUFFIX } \\ -40^{\circ} \mathrm{C} \text { to } 85^{\circ} \mathrm{C} \end{gathered}$ |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | $\mathrm{V}+=15 \mathrm{~V}, \mathrm{~V}-=-15 \mathrm{~V}$ | N |  |  | MAX |  |
|  |  | $\mathrm{V}_{\mathrm{AL}}=0.8 \mathrm{~V}, \mathrm{~V}_{\mathrm{AH}}=2.4 \mathrm{~V}^{\text {f }}$ | MN |  |  | MAX |  |
| Analog Switch |  |  |  |  |  |  |  |  |
| Analog Signal Range ${ }^{\text {e }}$ |  |  | $\mathrm{V}_{\text {ANALOG }}$ |  | Full | - | 0 | 12 | V |
| Drain-Source On-Resistance |  |  | $\mathrm{R}_{\text {DS(on) }}$ | $V_{D}=3 \mathrm{~V}, \mathrm{I}_{\mathrm{S}}=-1 \mathrm{~mA}$ sequence each switch on | Room | 78 | - | 100 | $\Omega$ |
| $\mathrm{R}_{\mathrm{DS}(o n)}$ Matching Between Channels ${ }^{9}$ |  | $\Delta \mathrm{R}_{\text {DS(on) }}$ | Room |  | 5 | - | - | \% |
| Source Off Leakage Current ${ }^{\text {a }}$ |  | $\mathrm{I}_{\text {(off) }}$ | $\begin{gathered} \mathrm{V}_{\mathrm{D}}=10 \mathrm{~V} \text { or } 0.5 \mathrm{~V}, \\ \mathrm{~V}_{\mathrm{S}}=0.5 \mathrm{~V} \text { or } 10 \mathrm{~V}, \\ \mathrm{~V}_{\mathrm{EN}}=0 \mathrm{~V} \end{gathered}$ | Room | - | -0.5 | 0.5 | $n A$ |
| Drain Off Leakage Current | DG406B | $I_{\text {( (off) }}$ |  | Room | - | -1 | 1 |  |
|  | DG407B |  |  | Room | - | -1 | 1 |  |
| Drain On Leakage Current | DG406B | $\mathrm{I}_{\mathrm{D} \text { (on) }}$ | $V_{S}=V_{D}= \pm 10 \mathrm{~V}$ <br> sequence each switch on | Room | - | -1 | 1 |  |
|  | DG407B |  |  | Room | - | -1 | 1 |  |
| Dynamic Characteristics |  |  |  |  |  |  |  |  |
| Transition Time |  | $t_{\text {TRANS }}$ | $\begin{gathered} \mathrm{V}_{\mathrm{S} 1}=8 \mathrm{~V}, \mathrm{~V}_{\mathrm{S} 8}=0 \mathrm{~V}, \\ \mathrm{~V}_{\mathrm{IN}}=2.4 \mathrm{~V} \end{gathered}$ | Room | 130 | - | 163 | ns |
| Enable Turn-On Time |  | $\mathrm{t}_{\mathrm{ON}(\mathrm{EN})}$ | $\begin{gathered} \mathrm{V}_{\mathrm{INH}}=2.4 \mathrm{~V}, \mathrm{~V}_{\mathrm{INL}}=0 \mathrm{~V}, \\ \mathrm{~V}_{\mathrm{IN}}=5 \mathrm{~V} \end{gathered}$ | Room | 93 | - | 125 |  |
| Enable Turn-Off Time |  | $\mathrm{t}_{\text {OFF (EN) }}$ |  | Room | 63 | - | 94 |  |
| Charge Injection |  | Q | $\begin{gathered} \mathrm{C}_{\mathrm{L}}=1 \mathrm{nF}, \mathrm{~V}_{\mathrm{S}}=6 \mathrm{~V} \\ \mathrm{R}_{\mathrm{S}}=0 \Omega \end{gathered}$ | Room | 9 | - | - | pC |
| Power Supplies |  |  |  |  |  |  |  |  |
| Positive Supply Current |  | I+ | $\begin{aligned} & \mathrm{V}_{\mathrm{EN}}=0 \mathrm{~V} \text { or } 5 \mathrm{~V} \\ & \mathrm{~V}_{\mathrm{A}}=0 \mathrm{~V} \text { or } 5 \mathrm{~V} \end{aligned}$ | Room | 13 | - | 30 | $\mu \mathrm{A}$ |
|  |  | Full |  | - | - | 75 |  |
| Positive Supply Current |  |  |  | I+ | Room | -0.01 | -20 |  | - |
|  |  | Full |  |  | - | -20 | - |  |

## Notes

a. Guaranteed by $\pm 15 \mathrm{~V}$ leakage test, not production tested.
b. Room $=25^{\circ} \mathrm{C}$, Full $=$ as determined by the operating temperature suffix.
c. Typical values are for DESIGN AID ONLY, not guaranteed nor subject to production testing.
d. The algebraic convention whereby the most negative value is a minimum and the most positive a maximum, is used in this datasheet.
e. Guaranteed by design, not subject to production test.
f. $V_{I N}=$ input voltage to perform proper function.
g. $\Delta R_{D S(o n)}=R_{D S(o n)}$ max. $-R_{D S(o n)}$ min.
h. Worst case isolation occurs on channel 4 due to proximity to the drain pin.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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TYPICAL CHARACTERISTICS $\left(\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}\right.$, unless otherwise noted)


On-Resistance vs. $V_{D}$ and Dual Supply Voltage


On-Resistance vs. $V_{D}$ and Temperature



On-Resistance vs. $V_{D}$ and Unipolar Supply Voltage


On-Resistance vs. $\mathrm{V}_{\mathrm{D}}$ and Temperature


Leakage vs. Current

TYPICAL CHARACTERISTICS $\left(\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}\right.$, unless otherwise noted)


Supply Current vs. Input Switching Frequency


Switching Time vs. Single Supplies


Insertion Loss, Off -Isolation Crosstalk vs. Frequency


Switching Time vs. Bipolar Supplies


Switching Threshold vs. Supply Voltage


Charge Injection vs. Analog Voltage

TYPICAL CHARACTERISTICS $\left(\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}\right.$, unless otherwise noted)


Switching Time vs. Temperature

SCHEMATIC DIAGRAM (Typical Channel)


Fig. 1

## TEST CIRCUITS



Fig. 2 - Transition Time


Fig. 3 - Enable Switching Time

## TEST CIRCUITS



Fig. 4 - Break-Before-Make Interval

[^0]

| $\operatorname{Dim}$ | MILLIMETERS |  | INCHES |  |
| :---: | :---: | :---: | :---: | :---: |
|  | Min | Max | Min | Max |
| $\mathbf{A}$ | 2.29 | 5.08 | 0.090 | 0.200 |
| $\mathbf{A}_{\mathbf{1}}$ | 0.39 | 1.77 | 0.015 | 0.070 |
| $\mathbf{B}$ | 0.38 | 0.56 | 0.015 | 0.022 |
| $\mathbf{B}_{\mathbf{1}}$ | 0.89 | 1.65 | 0.035 | 0.065 |
| $\mathbf{C}$ | 0.204 | 0.30 | 0.008 | 0.012 |
| $\mathbf{D}$ | 35.10 | 39.70 | 1.380 | 1.565 |
| $\mathbf{E}$ | 15.24 | 15.88 | 0.600 | 0.625 |
| $\mathbf{E}_{\mathbf{1}}$ | 13.21 | 14.73 | 0.520 | 0.580 |
| $\mathbf{E}_{\mathbf{1}}$ | 2.29 | 2.79 | 0.090 | 0.110 |
| $\mathbf{\mathbf { Q A } _ { \mathbf { A } }}$ | 14.99 | 15.49 | 0.590 | 0.610 |
| $\mathbf{L}$ | 2.60 | 5.08 | 0.100 | 0.200 |
| $\mathbf{Q}_{\mathbf{1}}$ | 0.95 | 2.345 | 0.0375 | 0.0925 |
| $\mathbf{S}$ | 0.995 | 2.665 | 0.0375 | 0.105 |
| ECN: S-03946-Rev. F, 09-Jul-01 |  |  |  |  |
| DWG: 5488 |  |  |  |  |

## PLCC: 28-LEAD



| DIM. | MILLIMETERS |  | INCHES |  |
| :---: | :---: | :---: | :---: | :---: |
|  | MIN. | MAX. | MIN. | MAX. |
| A | 4.20 | 4.57 | 0.165 | 0.180 |
| $\mathrm{~A}_{1}$ | 2.29 | 3.04 | 0.090 | 0.120 |
| $\mathrm{~A}_{2}$ | 0.51 | - | 0.020 | - |
| B | 0.331 | 0.553 | 0.013 | 0.021 |
| $\mathrm{~B}_{1}$ | 0.661 | 0.812 | 0.026 | 0.032 |
| D | 12.32 | 12.57 | 0.485 | 0.495 |
| $\mathrm{D}_{1}$ | 11.430 | 11.582 | 0.450 | 0.456 |
| $\mathrm{D}_{2}$ | 9.91 | 10.92 | 0.390 | 0.430 |
| $\mathrm{e}_{1}$ | 1.27 BSC |  | 0.050 BSC |  |

ECN: T09-0766-Rev. D, 28-Sep-09
DWG: 5491

## SOIC (WIDE-BODY): 28-LEADS



All Dimensions In Inches

ECN: E11-2209-Rev. D, 01-Aug-11
DWG: 5850

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